

General Description

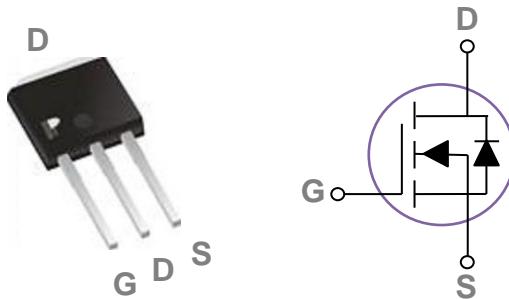
These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

BVDSS	RDS(ON)	ID
40V	6.4mΩ	70A

Features

- 40V, 70A, RDS(ON) = 6.4mΩ@VGS = 10V
- Improved dv/dt capability
- Fast switching
- Green Device Available

TO251 Pin Configuration



Applications

- MB / VGA / Vcore
- POL Applications
- SMPS 2nd SR

Absolute Maximum Ratings $T_c=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Rating	Units
V _{Ds}	Drain-Source Voltage	40	V
V _{Gs}	Gate-Source Voltage	± 20	V
I _D	Drain Current – Continuous ($T_c=25^\circ\text{C}$)	70	A
	Drain Current – Continuous ($T_c=100^\circ\text{C}$)	44	A
I _{DM}	Drain Current – Pulsed ¹	280	A
EAS	Single Pulse Avalanche Energy ²	61	mJ
IAS	Single Pulse Avalanche Current ²	35	A
P _D	Power Dissipation ($T_c=25^\circ\text{C}$)	54.3	W
	Power Dissipation – Derate above 25°C	0.43	W/°C
T _{STG}	Storage Temperature Range	-55 to 150	°C
T _J	Operating Junction Temperature Range	-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit
R _{θJA}	Thermal Resistance Junction to ambient	---	62	°C/W
R _{θJC}	Thermal Resistance Junction to Case	---	2.3	°C/W

Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)
Off Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$, $I_D=250\mu\text{A}$	40	---	---	V
$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	BV_{DSS} Temperature Coefficient	Reference to 25°C , $I_D=1\text{mA}$	---	0.03	---	$^\circ\text{C}$
I_{DSS}	Drain-Source Leakage Current	$V_{\text{DS}}=40\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=25^\circ\text{C}$	---	---	1	μA
		$V_{\text{DS}}=32\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=125^\circ\text{C}$	---	---	10	μA
I_{GSS}	Gate-Source Leakage Current	$V_{\text{GS}}=\pm 20\text{V}$, $V_{\text{DS}}=0\text{V}$	---	---	± 100	nA

On Characteristics

$R_{\text{DS(ON)}}$	Static Drain-Source On-Resistance ³	$V_{\text{GS}}=10\text{V}$, $I_D=20\text{A}$	---	5.3	6.4	$\text{m}\Omega$
		$V_{\text{GS}}=10\text{V}$, $I_D=20\text{A}$ ($T_J=125^\circ\text{C}$)	---	8.1	---	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}$, $I_D=10\text{A}$	---	6.8	8.8	$\text{m}\Omega$
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}$, $I_D = 250\mu\text{A}$	1.2	1.6	2.5	V
$\Delta V_{\text{GS(th)}}$	$V_{\text{GS(th)}}$ Temperature Coefficient		---	-4.2	---	$\text{mV}/^\circ\text{C}$
g_{fs}	Forward Transconductance	$V_{\text{DS}}=10\text{V}$, $I_D=3\text{A}$	---	12	---	S

Dynamic Characteristics

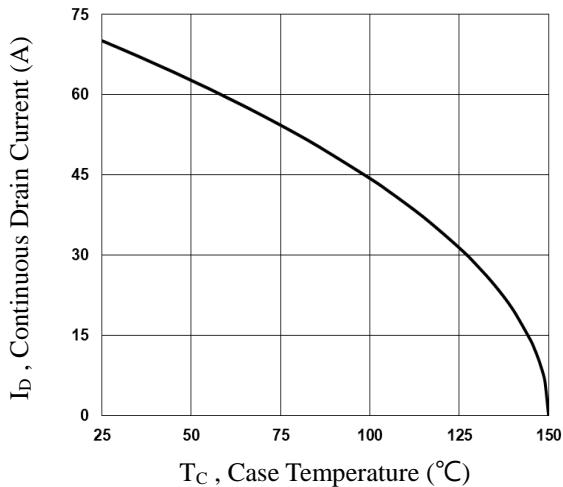
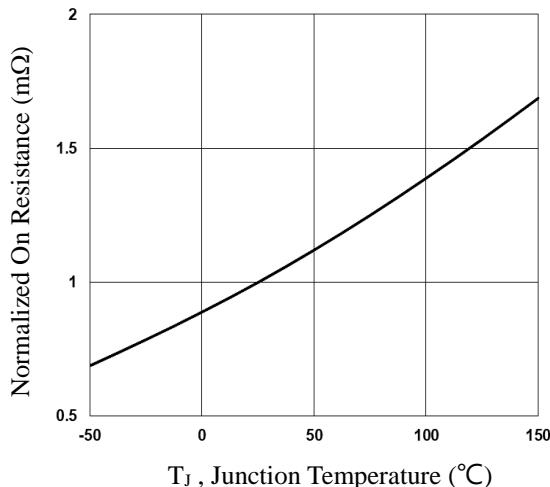
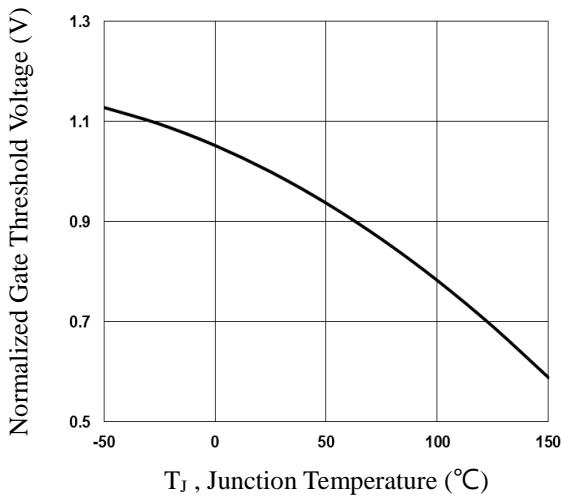
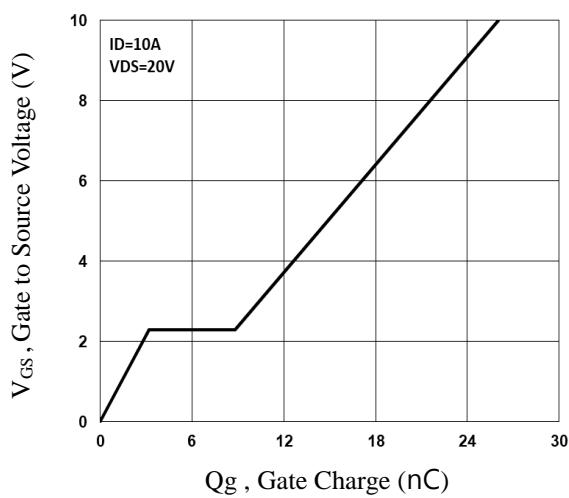
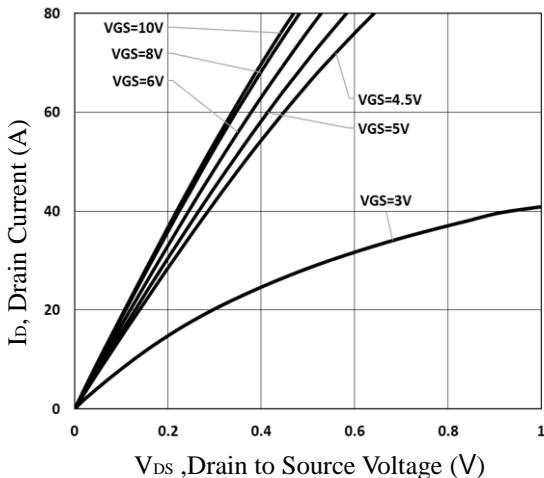
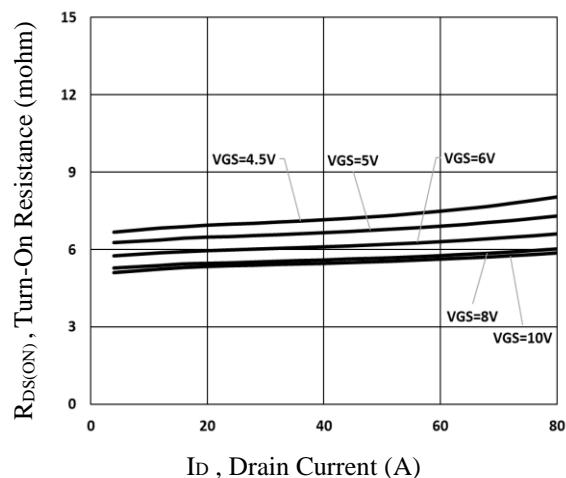
Q_g	Total Gate Charge ^{3,4}	$V_{\text{DS}}=20\text{V}$, $V_{\text{GS}}=10\text{V}$, $I_D=10\text{A}$	---	26	62	nC
Q_{gs}	Gate-Source Charge ^{3,4}		---	3.2	7	
Q_{gd}	Gate-Drain Charge ^{3,4}		---	5.6	11	
$T_{\text{d(on)}}$	Turn-On Delay Time ^{3,4}	$V_{\text{DD}}=15\text{V}$, $V_{\text{GS}}=10\text{V}$, $R_G=6\Omega$	---	13.6	25	ns
T_r	Rise Time ^{3,4}		---	2.5	5	
$T_{\text{d(off)}}$	Turn-Off Delay Time ^{3,4}		---	68	120	
T_f	Fall Time ^{3,4}		---	5	10	
C_{iss}	Input Capacitance	$V_{\text{DS}}=20\text{V}$, $V_{\text{GS}}=0\text{V}$, $F=1\text{MHz}$	---	1660	3320	pF
C_{oss}	Output Capacitance		---	203	400	
C_{rss}	Reverse Transfer Capacitance		---	132	165	
R_g	Gate resistance	$V_{\text{GS}}=0\text{V}$, $V_{\text{DS}}=0\text{V}$, $F=1\text{MHz}$	---	1.6	3.2	Ω

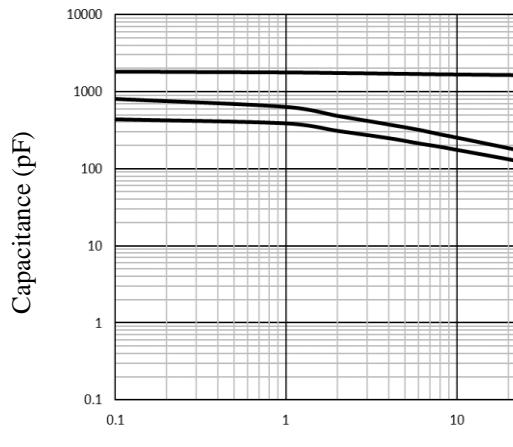
Drain-Source Diode Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I_s	Continuous Source Current	$V_G=V_D=0\text{V}$, Force Current	---	---	70	A
I_{SM}	Pulsed Source Current ³		---	---	140	A
V_{SD}	Diode Forward Voltage ³	$V_{\text{GS}}=0\text{V}$, $I_s=1\text{A}$, $T_J=25^\circ\text{C}$	---	---	1	V
t_{rr}	Reverse Recovery Time		---	42.6	---	ns
Q_{rr}	Reverse Recovery Charge	$T_J=25^\circ\text{C}$	---	28.1	---	nC

Note :

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. $V_{\text{DD}}=25\text{V}$, $V_{\text{GS}}=10\text{V}$, $L=0.1\text{mH}$, $I_{\text{AS}}=35\text{A}$, Starting $T_J=25^\circ\text{C}$
3. The data tested by pulsed , pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.
4. Essentially independent of operating temperature.


Fig.1 Continuous Drain Current vs. T_c

Fig.2 Normalized RDSON vs. T_j

Fig.3 Normalized V_{th} vs. T_j

Fig.4 Gate Charge Waveform

Fig.5 Typical Output Characteristics

Fig.6 Turn-On Resistance vs. ID



V_{DS}, Drain to Source Voltage (V)

Fig.7 Capacitance Characteristics

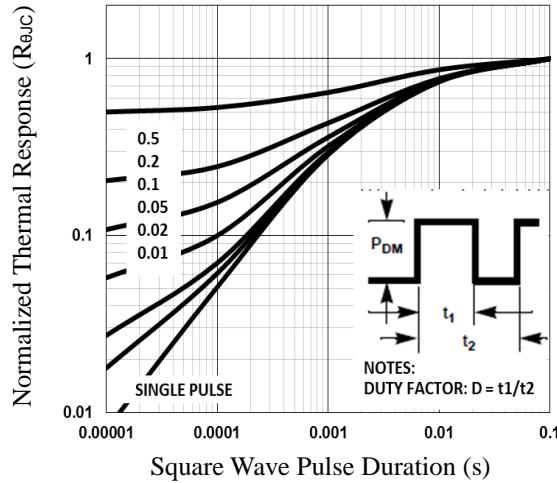


Fig.8 Normalized Transient Impedance

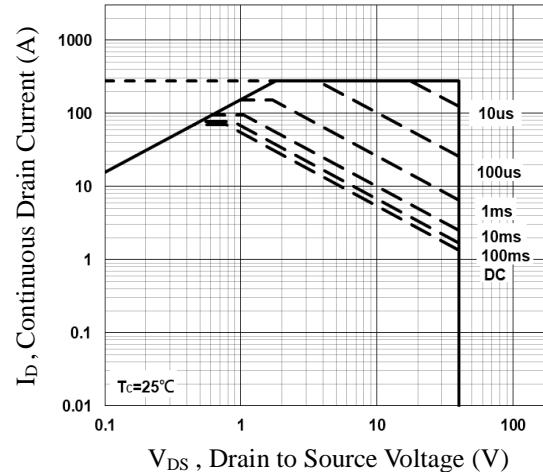


Fig.9 Maximum Safe Operation Area

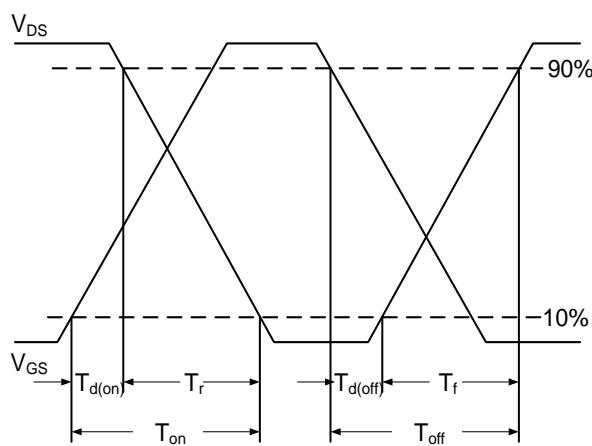


Fig.10 Switching Time Waveform

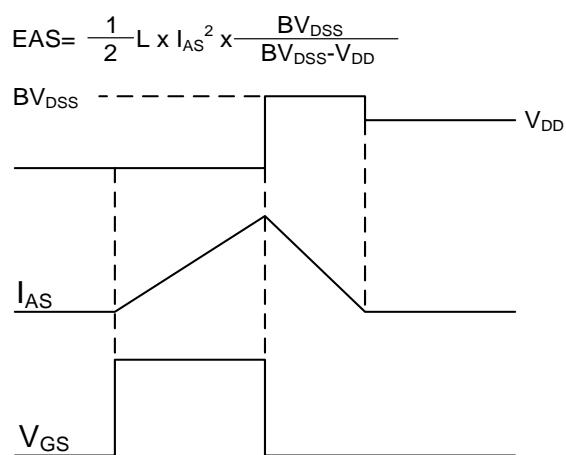
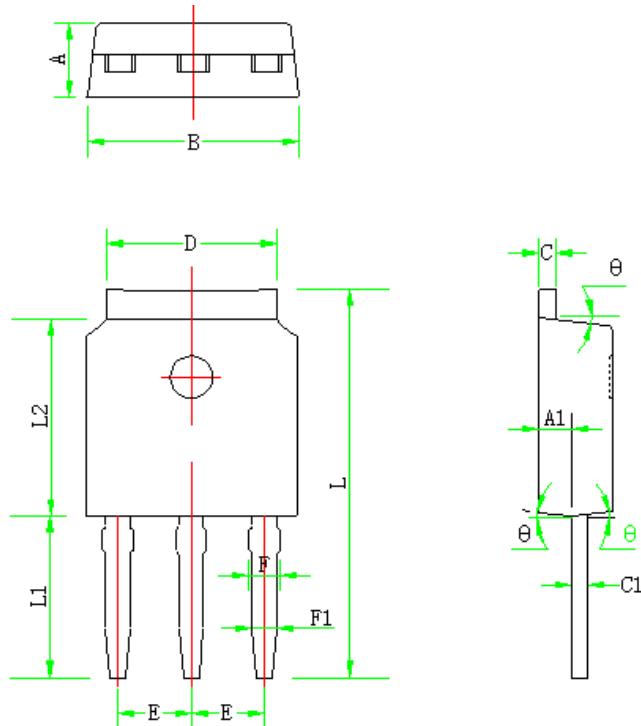


Fig.11 EAS Waveform

TO251 PACKAGE INFORMATION



symbol	Dimensions In Millimeters		
	Min	Nom	Max
A	2.20	2.3	2.40
A1	0.91	1.01	1.11
B	6.50	6.6	6.70
C	0.46	0.508	0.580
C1	0.46	0.508	0.580
D	5.10	5.32	5.46
E	2.186	2.286	2.386
F	0.74	0.84	0.94
F1	0.660	0.76	0.860
L	11.70	12.00	12.30
L1	4.8	5.0	5.2
L2	6.00	6.1	6.20
θ	3°	7°	9°